

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/785,294	LEE, YEOU-CHING
	Examiner	Art Unit
	EDMUND H. LEE	1732

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
264	139,247	6/12/2006	EHL
	25,274		
	275		